DESCRIPTION
The MP1924A is a high-frequency, half-bridge, N-channel power MOSFET driver. Its low-side and high-side driver channels are controlled independently and matched with less than 5ns of time delay. Under-voltage lockout (UVLO) on both the high-side and low-side supplies forces the outputs low in the event that the supply is insufficient. The integrated bootstrap diode reduces the external component count.

The MP1924A is available in QFN-10 (4mmx4mm) and SOIC-8 packages.

FEATURES
- Drives an N-Channel MOSFET Half-Bridge
- 115V Bootstrap Voltage Range
- On-Chip Bootstrap Diode
- Typical Propagation Delay of 20ns
- Gate Driver Matching of Less than 5ns
- Drives a 2.2nF Load with 15ns of Rise Time and 12ns of Fall Time at 12V VDD
- TTL-Compatible Input
- Quiescent Current of Less than 150µA
- UVLO for Both High-Side and Low-Side Gate Drivers
- QFN-10 (4mmx4mm) and SOIC-8 Packages

APPLICATIONS
- Motor Drivers
- Telecom Half-Bridge Power Supplies
- Avionics DC/DC Converters
- Two-Switch Forward Converters
- Active Clamp Forward Converters

All MPS parts are lead-free, halogen free, and adhere to the RoHS directive. For MPS green status, please visit the MPS website under Quality Assurance.

“MPS” and “The Future of Analog IC Technology” are registered trademarks of Monolithic Power Systems, Inc.
**ORDERING INFORMATION**

<table>
<thead>
<tr>
<th>Part Number</th>
<th>Package</th>
<th>Top Marking</th>
</tr>
</thead>
<tbody>
<tr>
<td>MP1924AHR*</td>
<td>QFN-10 (4mmx4mm)</td>
<td>See Below</td>
</tr>
<tr>
<td>MP1924AHS**</td>
<td>SOIC-8</td>
<td>See Below</td>
</tr>
</tbody>
</table>

* For Tape & Reel, add suffix –Z (e.g. MP1924AHR–Z)  
For RoHS compliant packaging, add suffix –LF (e.g. MP1924AHR–LF–Z)

** For Tape & Reel, add suffix –Z (e.g. MP1924AHS–Z)  
For RoHS compliant packaging, add suffix –LF (e.g. MP1924AHS–LF–Z)

**TOP MARKING (MP1924AHR)**

**MPSYWW**

**M1924A**

**LLLLLL**

MPS: MPS prefix  
Y: Year code  
WW: Week code  
M1924A: Product code of MP1924AHR  
LLLLLLL: Lot number

**TOP MARKING (MP1924AHS)**

**MP1924A**

**LLLLLLLL**

**MPSYWW**

MP1924A: Part number  
LLLLLLLL: Lot number  
MPS: MPS prefix  
Y: Year code  
WW: Week code
# Absolute Maximum Ratings

Supply voltage \( (V_{DD}) \) ...................... -0.3V to 18V  
SW voltage \( (V_{SW}) \) ...................... -5.0V to 105V  
BST voltage \( (V_{BST}) \) ...................... -0.3V to 115V  
BST to SW .............................. -0.3V to 18V  
DRVH to SW .............................. -0.3V to \( (V_{DD} + 0.3V) \)  
DRVL to VSS .............................. -0.3V to \( (V_{DD} + 0.3V) \)  
All other pins ............................. -0.3V to \( (V_{DD} + 0.3V) \)  
Continuous power dissipation \( (T_J = 25°C) \)  
QFN-10 (4mmx4mm) ....................... 2.66W  
SOIC-8 ........................................ 1.3W  
Junction temperature ................... 150°C  
Lead temperature ....................... 260°C  
Storage temperature ................... -65°C to 150°C  

# Recommended Operating Conditions

Supply voltage \( (V_{DD}) \) ...................... 8.0V to 15.0V  
SW voltage \( (V_{SW}) \) ...................... -1.0V to 100V  
SW slew rate ............................. <50V/\( ns \)  
Operating junction temp. \( (T_J = T_A) \)  
.............................................. -40°C to 125°C  

# Thermal Resistance

QFN-10 (4mmx4mm) ...................... 47 °C/W  
SOIC-8 ...................................... 96 °C/W  

# Notes

1) Exceeding these ratings may damage the device.  
2) The maximum allowable power dissipation is a function of the maximum junction temperature \( T_J \) (MAX), the junction-to-ambient thermal resistance \( \theta_{JA} \), and the ambient temperature \( T_A \). The maximum allowable continuous power dissipation at any ambient temperature is calculated by \( P_D \) (MAX) = \( (T_J(\text{MAX})-T_A)/\theta_{JA} \). Exceeding the maximum allowable power dissipation produces an excessive die temperature, causing the regulator to go into thermal shutdown. Internal thermal shutdown circuitry protects the device from permanent damage.  
3) The device is not guaranteed to function outside of its operating conditions.  
4) Measured on JESD51-7, 4-layer PCB.
# ELECTRICAL CHARACTERISTICS

\(V_{\text{DD}} = V_{\text{BST}} - V_{\text{SW}} = 12\text{V}, V_{\text{SS}} = V_{\text{SW}} = 0\text{V},\) no load at DRVH and DRVL, \(T_J = -40^\circ\text{C}\) to \(+125^\circ\text{C}\), typical value is tested at \(T_J = +25^\circ\text{C}\), unless otherwise noted.

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Symbol</th>
<th>Condition</th>
<th>Min</th>
<th>Typ</th>
<th>Max</th>
<th>Units</th>
</tr>
</thead>
<tbody>
<tr>
<td><strong>Supply Currents</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>VDD quiescent current</td>
<td>(I_{\text{DDQ}})</td>
<td>INL = INH = 0</td>
<td>100</td>
<td>150</td>
<td>µA</td>
<td></td>
</tr>
<tr>
<td>VDD operating current</td>
<td>(I_{\text{DDO}})</td>
<td>fsw = 500kHz</td>
<td>9</td>
<td>mA</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Floating driver quiescent current</td>
<td>(I_{\text{BSTQ}})</td>
<td>INL = INH = 0</td>
<td>60</td>
<td>90</td>
<td>µA</td>
<td></td>
</tr>
<tr>
<td>Floating driver operating current</td>
<td>(I_{\text{BSTO}})</td>
<td>fsw = 500kHz</td>
<td>7.5</td>
<td>mA</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Leakage current</td>
<td>(I_{\text{LK}})</td>
<td>BST = SW = 100V</td>
<td>0.05</td>
<td>1</td>
<td>µA</td>
<td></td>
</tr>
<tr>
<td><strong>Inputs</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>INL/INH high</td>
<td></td>
<td></td>
<td>2</td>
<td>2.4</td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>INL/INH low</td>
<td></td>
<td></td>
<td>1</td>
<td>1.4</td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>INL/INH internal pull-down resistance</td>
<td>(R_{\text{IN}})</td>
<td></td>
<td>185</td>
<td>kΩ</td>
<td></td>
<td></td>
</tr>
<tr>
<td><strong>Under-Voltage Protection</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>VDD rising threshold</td>
<td>(V_{\text{DDR}})</td>
<td></td>
<td>6</td>
<td>6.8</td>
<td>7.2</td>
<td>V</td>
</tr>
<tr>
<td>VDD hysteresis</td>
<td>(V_{\text{DDH}})</td>
<td></td>
<td>0.5</td>
<td></td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>BST-SW rising threshold</td>
<td>(V_{\text{BSTR}})</td>
<td></td>
<td>5.8</td>
<td>6.5</td>
<td>6.9</td>
<td>V</td>
</tr>
<tr>
<td>BST-SW hysteresis</td>
<td>(V_{\text{BSTH}})</td>
<td></td>
<td>0.5</td>
<td></td>
<td></td>
<td>V</td>
</tr>
<tr>
<td><strong>Bootstrap Diode</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Bootstrap diode VF at 100µA</td>
<td>(V_{\text{F1}})</td>
<td></td>
<td>0.5</td>
<td></td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>Bootstrap diode VF at 100mA</td>
<td>(V_{\text{F2}})</td>
<td></td>
<td>0.95</td>
<td></td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>Bootstrap diode dynamic R</td>
<td>(R_{\text{D}})</td>
<td>at 100mA</td>
<td></td>
<td>2.5</td>
<td></td>
<td>Ω</td>
</tr>
<tr>
<td><strong>Low-Side Gate Driver</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Low level output voltage</td>
<td>(V_{\text{OLL}})</td>
<td>(I_O = 100\text{mA})</td>
<td></td>
<td>0.1</td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>High level output voltage to rail</td>
<td>(V_{\text{OHL}})</td>
<td>(I_O = -100\text{mA})</td>
<td></td>
<td>0.36</td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>Source current(5)</td>
<td>(I_{\text{OHL}})</td>
<td>(V_{\text{DRVL}} = 0\text{V}, V_{\text{DD}} = 12\text{V})</td>
<td></td>
<td>3</td>
<td></td>
<td>A</td>
</tr>
<tr>
<td></td>
<td></td>
<td>(V_{\text{DRVL}} = 0\text{V}, V_{\text{DD}} = 16\text{V})</td>
<td></td>
<td>4.7</td>
<td></td>
<td>A</td>
</tr>
<tr>
<td>Sink current(5)</td>
<td>(I_{\text{OLL}})</td>
<td>(V_{\text{DRVL}} = V_{\text{DD}} = 12\text{V})</td>
<td></td>
<td>4.5</td>
<td></td>
<td>A</td>
</tr>
<tr>
<td></td>
<td></td>
<td>(V_{\text{DRVL}} = V_{\text{DD}} = 16\text{V})</td>
<td></td>
<td>6</td>
<td></td>
<td>A</td>
</tr>
<tr>
<td><strong>Floating Gate Driver</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Low level output voltage</td>
<td>(V_{\text{OLH}})</td>
<td>(I_O = 100\text{mA})</td>
<td></td>
<td>0.1</td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>High level output voltage to rail</td>
<td>(V_{\text{OHH}})</td>
<td>(I_O = -100\text{mA})</td>
<td></td>
<td>0.32</td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>Source current(5)</td>
<td>(I_{\text{OHH}})</td>
<td>(V_{\text{DRVH}} = 0\text{V}, V_{\text{DD}} = 12\text{V})</td>
<td></td>
<td>2.6</td>
<td></td>
<td>A</td>
</tr>
<tr>
<td></td>
<td></td>
<td>(V_{\text{DRVH}} = 0\text{V}, V_{\text{DD}} = 16\text{V})</td>
<td></td>
<td>4</td>
<td></td>
<td>A</td>
</tr>
<tr>
<td>Sink current(5)</td>
<td>(I_{\text{OLH}})</td>
<td>(V_{\text{DRVH}} = V_{\text{DD}} = 12\text{V})</td>
<td></td>
<td>4.5</td>
<td></td>
<td>A</td>
</tr>
<tr>
<td></td>
<td></td>
<td>(V_{\text{DRVH}} = V_{\text{DD}} = 16\text{V})</td>
<td></td>
<td>5.9</td>
<td></td>
<td>A</td>
</tr>
</tbody>
</table>

**NOTE:**

(5) Guaranteed by design.
### ELECTRICAL CHARACTERISTICS (continued)

$V_{DD} = V_{BST} - V_{SW} = 12V$, $V_{SS} = V_{SW} = 0V$, no load at $DRVH$ and $DRVL$, $T_J = -40°C$ to $+125°C$, typical value is tested at $T_J = +25°C$, unless otherwise noted.

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Symbol</th>
<th>Condition</th>
<th>Min</th>
<th>Typ</th>
<th>Max</th>
<th>Units</th>
</tr>
</thead>
<tbody>
<tr>
<td><strong>Switching Specification—Low-Side Gate Driver</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Turn-off propagation delay INL falling to DRVL falling</td>
<td>$T_{DLFF}$</td>
<td></td>
<td>20</td>
<td>ns</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Turn-on propagation delay INL rising to DRVL rising</td>
<td>$T_{DLRR}$</td>
<td></td>
<td>20</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>DRVL rise time</td>
<td>$C_L = 2.2nF$</td>
<td></td>
<td>15</td>
<td>ns</td>
<td></td>
<td></td>
</tr>
<tr>
<td>DRVL fall time</td>
<td>$C_L = 2.2nF$</td>
<td></td>
<td>15</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td><strong>Switching Specification—Floating Gate Driver</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Turn-off propagation delay INH falling to DRVH falling</td>
<td>$T_{DHFF}$</td>
<td></td>
<td>20</td>
<td>ns</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Turn-on propagation delay INH rising to DRVH rising</td>
<td>$T_{DHRR}$</td>
<td></td>
<td>20</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>DRVH rise time</td>
<td>$C_L = 2.2nF$</td>
<td></td>
<td>15</td>
<td>ns</td>
<td></td>
<td></td>
</tr>
<tr>
<td>DRVH fall time</td>
<td>$C_L = 2.2nF$</td>
<td></td>
<td>15</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td><strong>Switching Specification—Matching</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Floating driver turn-off to low side driver turn-on$^{(5)}$</td>
<td>$T_{MON}$</td>
<td></td>
<td>1</td>
<td>5</td>
<td>ns</td>
<td></td>
</tr>
<tr>
<td>Low-side driver turn-off to floating driver turn-on$^{(5)}$</td>
<td>$T_{MOFF}$</td>
<td></td>
<td>1</td>
<td>5</td>
<td>ns</td>
<td></td>
</tr>
<tr>
<td>Minimum input pulse width that changes the output$^{(5)}$</td>
<td>$T_{PW}$</td>
<td></td>
<td></td>
<td></td>
<td>50</td>
<td>ns</td>
</tr>
<tr>
<td>Bootstrap diode turn-on or turn-off time$^{(5)}$</td>
<td>$T_{BS}$</td>
<td></td>
<td>10</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Thermal shutdown</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td>150</td>
</tr>
<tr>
<td>Thermal shutdown hysteresis</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td>25</td>
</tr>
</tbody>
</table>

**NOTE:**

6) Guaranteed by design.
TYPICAL PERFORMANCE CHARACTERISTICS

$V_{DD} = 12V, V_{SS} = V_{SW} = 0V, T_A = +25^\circ C$, unless otherwise noted.

- **IDDO Operation Current vs. Frequency**
- **IBSTO Operation Current vs. Frequency**
- **High-Level Output Voltage vs. Temperature**
- **Low-Level Output Voltage vs. Temperature**
- **Under-Voltage Lockout Threshold vs. Temperature**
- **Under-Voltage Lockout Hysteresis vs. Temperature**
- **Bootstrap Diode I-V Characteristic**
- **Quiescent Current vs. Voltage**
- **Propagation Delay vs. Temperature**
TYPICAL PERFORMANCE CHARACTERISTICS (continued)

$V_{DD} = 12V$, $V_{SS} = V_{SW} = 0V$, $T_A = +25^\circ C$, unless otherwise noted.

**Sink Current vs. $V_{DD}$ Voltage**

**Source Current vs. $V_{DD}$ Voltage**

**Source Current vs. Output Voltage**

$V_{DD} = 12V$

**Sink Current vs. Output Voltage**

$V_{DD} = 12V$
TYPICAL PERFORMANCE CHARACTERISTICS (continued)

$V_{DD} = 12V$, $V_{SS} = V_{SW} = 0V$, $T_A = +25^\circ C$, unless otherwise noted.

### Turn-On Propagation Delay

**Graph:**
- INL
- INH
- DRVL
- DRVH

### Turn-Off Propagation Delay

**Graph:**
- INL
- INH
- DRVL
- DRVH

### Gate Drive Matching $T_{MOFF}$

**Graph:**
- INH
- INL
- DRVH
- DRVL

### Gate Drive Matching $T_{MON}$

**Graph:**
- INH
- INL
- DRVL
- DRVH

### Drive Rise Time

**Graph:**
- 2.2nF Load

### Drive Fall Time

**Graph:**
- 2.2nF Load
## PIN FUNCTIONS

<table>
<thead>
<tr>
<th>QFN-10 Pin #</th>
<th>SOIC-8 Pin #</th>
<th>Name</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>1</td>
<td>1</td>
<td>VDD</td>
<td>Supply input. VDD supplies power to the internal circuitry. Place a decoupling capacitor on ground close to VDD to ensure a stable and clean supply.</td>
</tr>
<tr>
<td>2</td>
<td>2</td>
<td>BST</td>
<td>Bootstrap. BST is the positive power supply for the internal floating high-side MOSFET driver. Connect a bypass capacitor between BST and SW.</td>
</tr>
<tr>
<td>3</td>
<td>3</td>
<td>DRVH</td>
<td>Floating driver output.</td>
</tr>
<tr>
<td>4</td>
<td>4</td>
<td>SW</td>
<td>Switching node.</td>
</tr>
<tr>
<td>5, 6</td>
<td></td>
<td>NC</td>
<td>No connection.</td>
</tr>
<tr>
<td>7</td>
<td>5</td>
<td>INH</td>
<td>Control signal input for the floating driver.</td>
</tr>
<tr>
<td>8</td>
<td>6</td>
<td>INL</td>
<td>Control signal input for the low-side driver.</td>
</tr>
<tr>
<td>9</td>
<td>7</td>
<td>VSS, Exposed Pad</td>
<td>Chip ground. Connect the exposed pad to VSS for proper thermal operation.</td>
</tr>
<tr>
<td>10</td>
<td>8</td>
<td>DRVL</td>
<td>Low-side driver output.</td>
</tr>
</tbody>
</table>
Figure 1: Timing Diagram
FUNCTIONAL BLOCK DIAGRAM

Figure 2: Functional Block Diagram
APPLICATION INFORMATION

The input signals of INH and INL can be controlled independently. If both INH and INL control the high-side and low-side MOSFETs of the same bridge, set a sufficient dead time between INH and INL low (and vice versa) to avoid a shoot-through (see Figure 3). Dead time is defined as the time interval between INH low and INL low.

![Shoot-Through Timing Diagram](image)

*Figure 3: Shoot-Through Timing Diagram*
REFERENCE DESIGN CIRCUITS

Half-Bridge Converter
The MP1924A drives the MOSFETs with alternating signals with dead time in half-bridge converter topology. The input voltage can rise up to 100V with the alternating signals INT and INL coming from the PWM controller (see Figure 4).

![Figure 4: Half-Bridge Converter](image)

Two-Switch Forward Converter
In two-switch forward converter topology, both MOSFETs are turned on and off simultaneously. The input signals INH and INL come from a PWM controller that senses the output voltage and output current during current-mode control. The Schottky diodes clamp the reverse swing of the power transformer and must be rated for the input voltage. The input voltage can rise up to 100V (see Figure 5).

![Figure 5: Two-Switch Forward Converter](image)
Active Clamp Forward Converter

In active clamp forward converter topology, the MP1924A drives the MOSFETs with alternating signals. The high-side MOSFET, in conjunction with $C_{reset}$, is used to reset the power transformer in a lossless manner.

This topology is optimal for running at duty cycles exceeding 50%. The device may not be able to run at 100V under this topology (see Figure 6).

![Figure 6: Active Clamp Forward Converter](image-url)
PACKAGE INFORMATION

QFN-10 (4mmx4mm)

NOTE:

1) ALL DIMENSIONS ARE IN MILLIMETERS.
2) EXPOSED PADDLE SIZE DOES NOT INCLUDE MOLD FLASH.
3) LEAD COPLANARITY SHALL BE 0.10 MILLIMETERS MAX.
4) JEDEC REFERENCE IS MO-220.
5) DRAWING IS NOT TO SCALE.

RECOMMENDED LAND PATTERN
SOIC-8

**NOTICE:** The information in this document is subject to change without notice. Users should warrant and guarantee that third party Intellectual Property rights are not infringed upon when integrating MPS products into any application. MPS will not assume any legal responsibility for any said applications.

**NOTE:**
1) CONTROL DIMENSION IS IN INCHES. DIMENSION IN BRACKET IS IN MILLIMETERS.
2) PACKAGE LENGTH DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.
3) PACKAGE WIDTH DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSIONS.
4) LEAD COPLANARITY (BOTTOM OF LEADS AFTER FORMING) SHALL BE 0.004" INCHES MAX.
5) DRAWING CONFORMS TO JEDEC MS-012, VARIATION AA.
6) DRAWING IS NOT TO SCALE.